

# MOSFET – N-Channel, Shielded Gate, POWERTRENCH® 150 V, 62 A, 12.4 mΩ

## FDMS86255

### Description

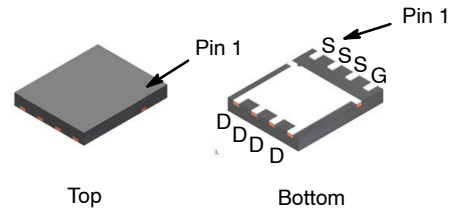
This N-Channel MOSFET is produced using **onsemi** advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

### Features

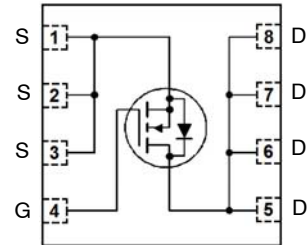
- Shielded Gate MOSFET Technology
- Max  $R_{DS(on)}$  = 12.4 mΩ at  $V_{GS} = 10$  V,  $I_D = 10$  A
- Max  $R_{DS(on)}$  = 15.5 mΩ at  $V_{GS} = 6$  V,  $I_D = 8$  A
- Advanced Package and Silicon Combination for Low  $R_{DS(on)}$  and High Efficiency
- Next Generation Enhanced Body Diode Technology, Engineered for Soft Recovery
- MSL1 Robust Package Design
- 100% UIL Tested
- RoHS Compliant
- These Device is Halogen Free

### Applications

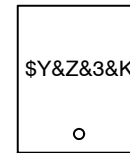
- OringFET / Load Switching
- Synchronous Rectification
- DC-DC Conversion



PQFN8 5X6, 1.27P  
 CASE 483AG



### MARKING DIAGRAM



- \$Y = Logo
- &Z = Assembly Location
- &3 = Date Code (Year and Week)
- &K = Specific Device Code

### ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

# FDMS86255

## MOSFET MAXIMUM RATINGS $T_A = 25^\circ\text{C}$ unless otherwise noted

| Symbol         | Parameter   | Rating      | Unit             |
|----------------|---|-------------|------------------|
| $V_{DS}$       | Drain to Source Voltage                               | 150         | V                |
| $V_{GS}$       | Gate to Source Voltage                                | $\pm 20$    | V                |
| $I_D$          | Drain Current Continuous, $T_C = 25^\circ\text{C}$    | 62          | A                |
|                | Continuous, $T_A = 25^\circ\text{C}$ (Note 1a)        | 10          |                  |
|                | Pulsed (Note 4)                                       | 271         |                  |
| $E_{AS}$       | Single Pulse Avalanche Energy (Note 3)                | 541         | mJ               |
| $P_D$          | Power Dissipation, $T_C = 25^\circ\text{C}$           | 113         | W                |
|                | Power Dissipation, $T_A = 25^\circ\text{C}$ (Note 1a) | 2.7         |                  |
| $T_J, T_{STG}$ | Operating and Storage Junction Temperature Range      | -55 to +150 | $^\circ\text{C}$ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

## THERMAL CHARACTERISTICS

| Symbol          | Parameter   | Rating | Unit                      |
|-----------------|---|--------|---------------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case              | 1.1    | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 45     |                           |

## ELECTRICAL CHARACTERISTICS $T_A = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|--------|-----------|-----------------|------|------|------|------|
|--------|-----------|-----------------|------|------|------|------|

### OFF CHARACTERISTICS

|                                   |   |   |     |     |           |                            |
|-----------------------------------|---|---|-----|-----|-----------|----------------------------|
| $BV_{DSS}$                        | Drain to Source Breakdown Voltage         | $I_D = 250\ \mu\text{A}, V_{GS} = 0\ \text{V}$              | 150 | -   | -         | V                          |
| $\Delta BV_{DSS}$<br>$\Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\ \mu\text{A}$ , referenced to $25^\circ\text{C}$ | -   | 109 | -         | $\text{mV}/^\circ\text{C}$ |
| $I_{DSS}$                         | Zero Gate Voltage Drain Current           | $V_{DS} = 120\ \text{V}, V_{GS} = 0\ \text{V}$              | -   | -   | 1         | $\mu\text{A}$              |
| $I_{GSS}$                         | Gate to Source Leakage Current            | $V_{GS} = \pm 20\ \text{V}, V_{DS} = 0\ \text{V}$           | -   | -   | $\pm 100$ | nA                         |

### ON CHARACTERISTICS

|                                     |  |  |     |      |      |                            |
|-------------------------------------|--|--|-----|------|------|----------------------------|
| $V_{GS(th)}$                        | Gate to Source Threshold Voltage                         | $V_{GS} = V_{DS}, I_D = 250\ \mu\text{A}$                            | 2.0 | 3.0  | 4.0  | V                          |
| $\Delta V_{GS(th)}$<br>$\Delta T_J$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250\ \mu\text{A}$ , referenced to $25^\circ\text{C}$          | -   | -11  | -    | $\text{mV}/^\circ\text{C}$ |
| $R_{DS(on)}$                        | Static Drain to Source On Resistance                     | $V_{GS} = 10\ \text{V}, I_D = 10\ \text{A}$                          | -   | 9.5  | 12.4 | m $\Omega$                 |
|                                     |  | $V_{GS} = 6\ \text{V}, I_D = 8\ \text{A}$                            | -   | 11.5 | 15.5 |                            |
|                                     |  | $V_{GS} = 10\ \text{V}, I_D = 10\ \text{A}, T_J = 125^\circ\text{C}$ | -   | 19   | 25   |                            |
| $g_{FS}$                            | Forward Transconductance                                 | $V_{DS} = 5\ \text{V}, I_D = 10\ \text{A}$                           | -   | 35   | -    | S                          |

### DYNAMIC CHARACTERISTICS

|           |                              |   |     |      |      |          |
|-----------|------------------------------|---|-----|------|------|----------|
| $C_{ISS}$ | Input Capacitance            | $V_{DS} = 75\ \text{V}, V_{GS} = 0\ \text{V},$<br>$f = 1\ \text{MHz}$ | -   | 3200 | 4480 | pF       |
| $C_{OOS}$ | Output Capacitance           |   | -   | 291  | 410  | pF       |
| $C_{rss}$ | Reverse Transfer Capacitance |   | -   | 11   | 20   | pF       |
| $R_g$     | Gate Resistance              |   | 0.1 | 0.7  | 2.1  | $\Omega$ |

### SWITCHING CHARACTERISTICS

|              |                     |  |  |     |    |    |    |
|--------------|---------------------|--|--|-----|----|----|----|
| $t_{d(on)}$  | Turn-On Delay Time  | $V_{DD} = 75\ \text{V}, I_D = 10\ \text{A},$<br>$V_{GS} = 10\ \text{V}, R_{GEN} = 6\ \Omega$ | -  | 21  | 34 | ns |    |
| $t_r$        | Rise Time           |  | -  | 4.5 | 10 | ns |    |
| $t_{d(off)}$ | Turn-Off Delay Time |  | -  | 28  | 45 | ns |    |
| $t_f$        | Fall Time           |  | -  | 6.2 | 12 | ns |    |
| $Q_g$        | Total Gate Charge   | $V_{GS} = 0\ \text{V}$ to $10\ \text{V}$   | $V_{DD} = 75\ \text{V},$<br>$I_D = 10\ \text{A}$ | -   | 45 | 63 | nC |
| $Q_g$        | Total Gate Charge   | $V_{GS} = 0\ \text{V}$ to $6\ \text{V}$  |  | -   | 29 | 41 | nC |

# FDMS86255

## ELECTRICAL CHARACTERISTICS (continued) $T_A = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|--------|-----------|-----------------|------|------|------|------|
|--------|-----------|-----------------|------|------|------|------|

### SWITCHING CHARACTERISTICS

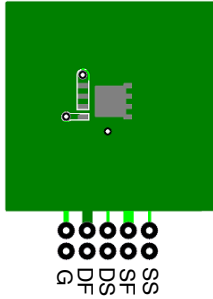
|                 |                               |  |   |     |   |    |
|-----------------|-------------------------------|--|---|-----|---|----|
| Q <sub>gs</sub> | Gate to Source Charge         |  | - | 14  | - | nC |
| Q <sub>gd</sub> | Gate to Drain "Miller" Charge |  | - | 8.8 | - | nC |

### DRAIN-SOURCE DIODE CHARACTERISTICS

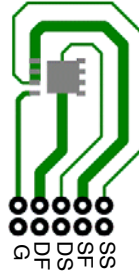
|                 |                                       |  |   |     |     |    |
|-----------------|---------------------------------------|--|---|-----|-----|----|
| V <sub>SD</sub> | Source to Drain Diode Forward Voltage | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.9 A (Note 2) | - | 0.7 | 1.2 | V  |
|                 |                                       | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10 A (Note 2)  | - | 0.8 | 1.3 |    |
| t <sub>rr</sub> | Reverse Recovery Time                 | I <sub>F</sub> = 10 A, di/dt = 100 A/μs                | - | 87  | 139 | ns |
| Q <sub>rr</sub> | Reverse Recovery Charge               |  | - | 165 | 264 | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- R<sub>θJA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>θJC</sub> is guaranteed by design while R<sub>θCA</sub> is determined by the user's board design.



a. 45°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b. 115°C/W when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.
- E<sub>AS</sub> of 541 mJ is based on starting T<sub>J</sub> = 25 °C, L = 3 mH, I<sub>AS</sub> = 19 A, V<sub>DD</sub> = 150 V, V<sub>GS</sub> = 10 V. 100% tested at L = 0.1 mH, I<sub>AS</sub> = 60 A.
- Pulse Id refers to Figure.11 Forward Bias Safe Operation Area.

TYPICAL CHARACTERISTICS  $T_J = 25^\circ\text{C}$  unless otherwise noted

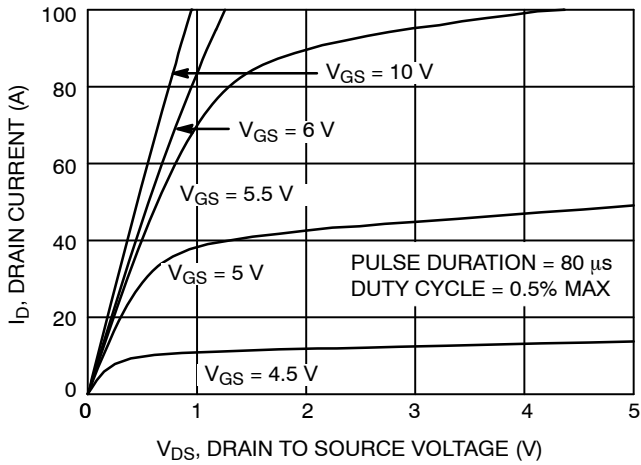


Figure 1. On-Region Characteristics

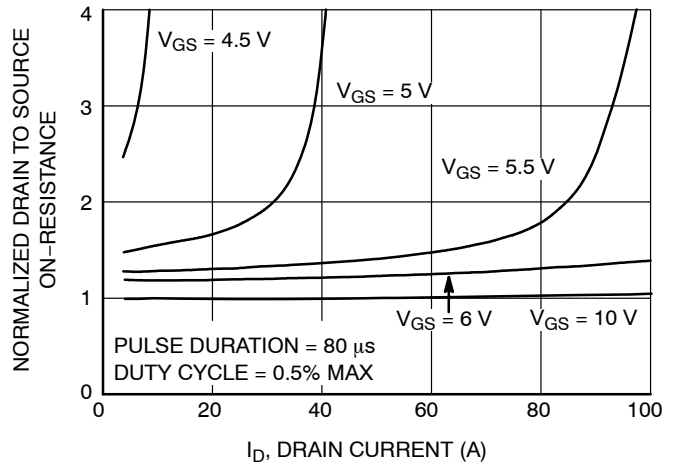


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

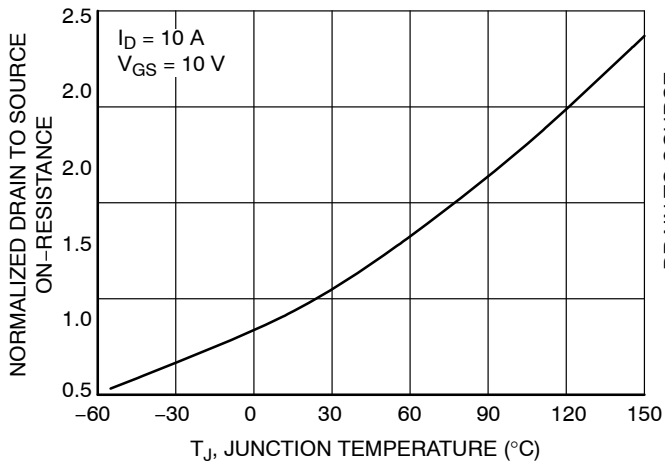


Figure 3. Normalized On-Resistance vs Junction Temperature

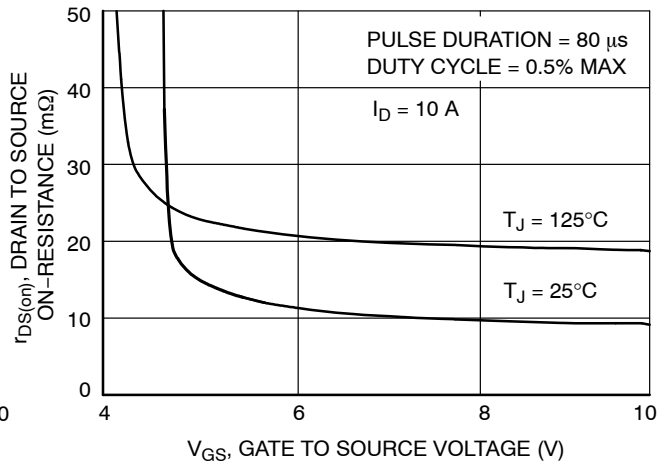


Figure 4. On-Resistance vs Gate to Source Voltage

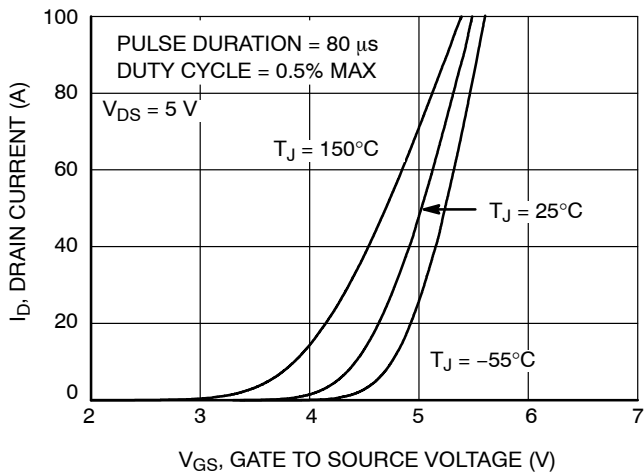


Figure 5. Transfer Characteristics

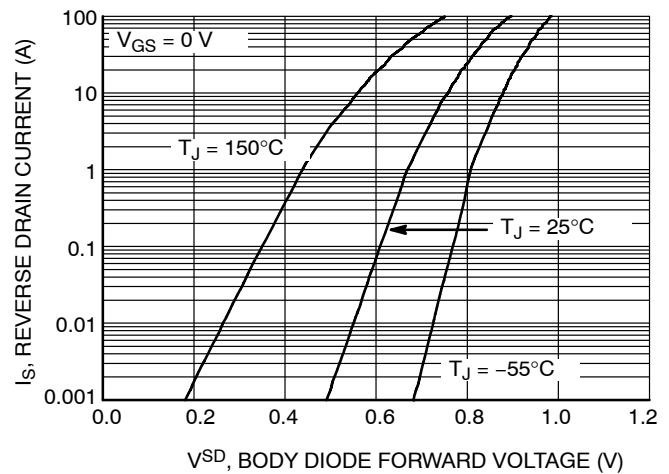


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

TYPICAL CHARACTERISTICS (continued)  $T_J = 25^\circ\text{C}$  unless otherwise noted

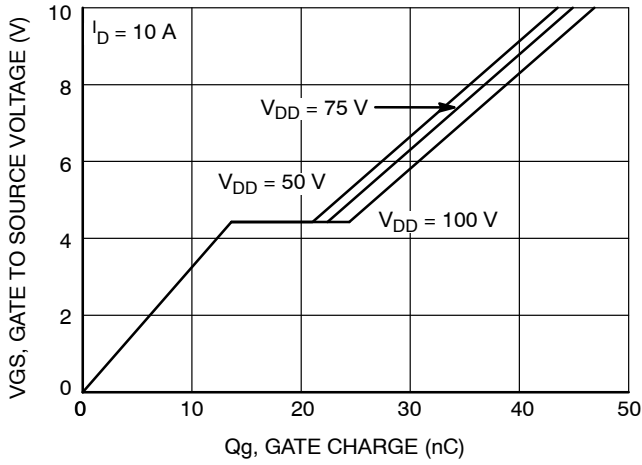


Figure 7. Gate Charge Characteristics

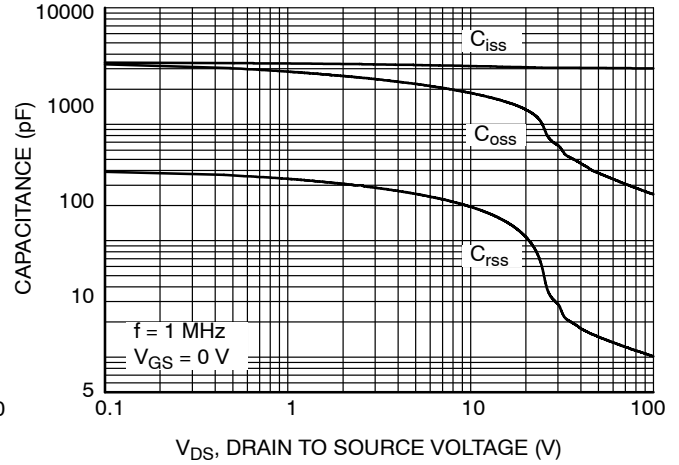


Figure 8. Capacitance vs Drain to Source Voltage

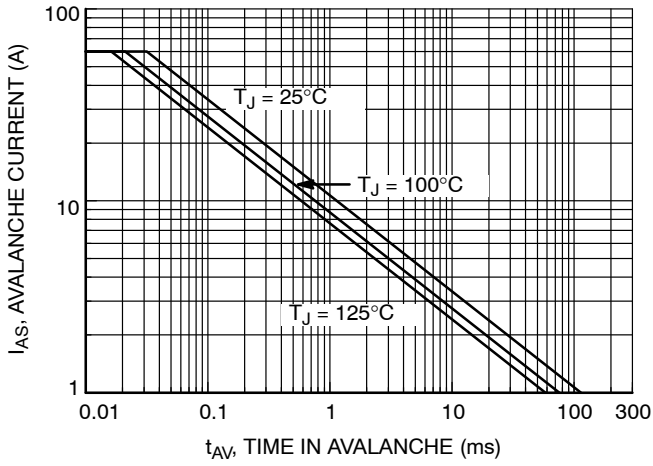


Figure 9. Unclamped Inductive Switching Capability

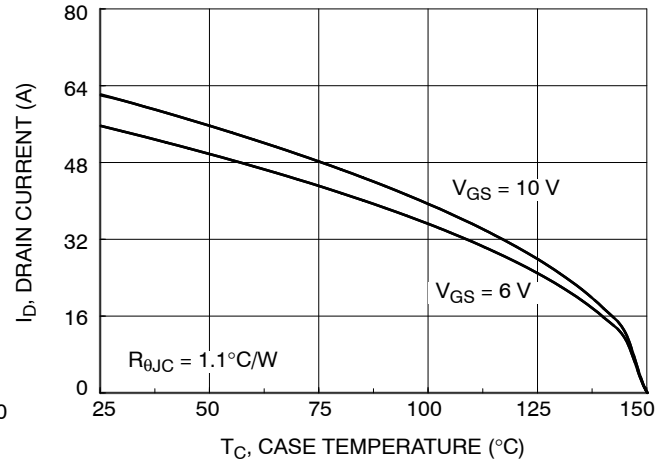


Figure 10. Maximum Continuous Drain Current vs Case Temperature

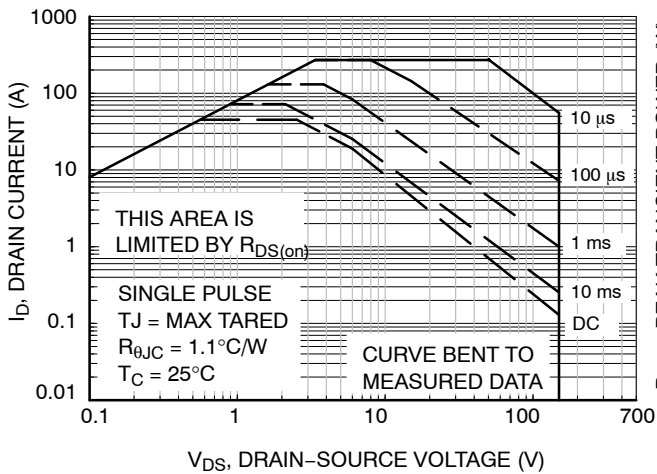


Figure 11. Forward Bias Safe Operating Area

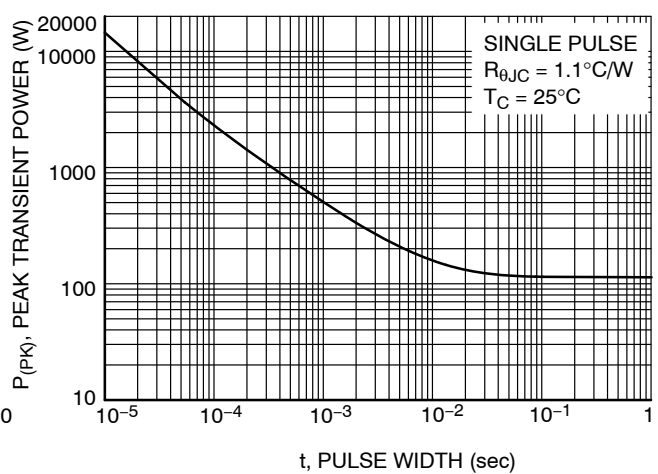


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)  $T_J = 25^\circ\text{C}$  unless otherwise noted

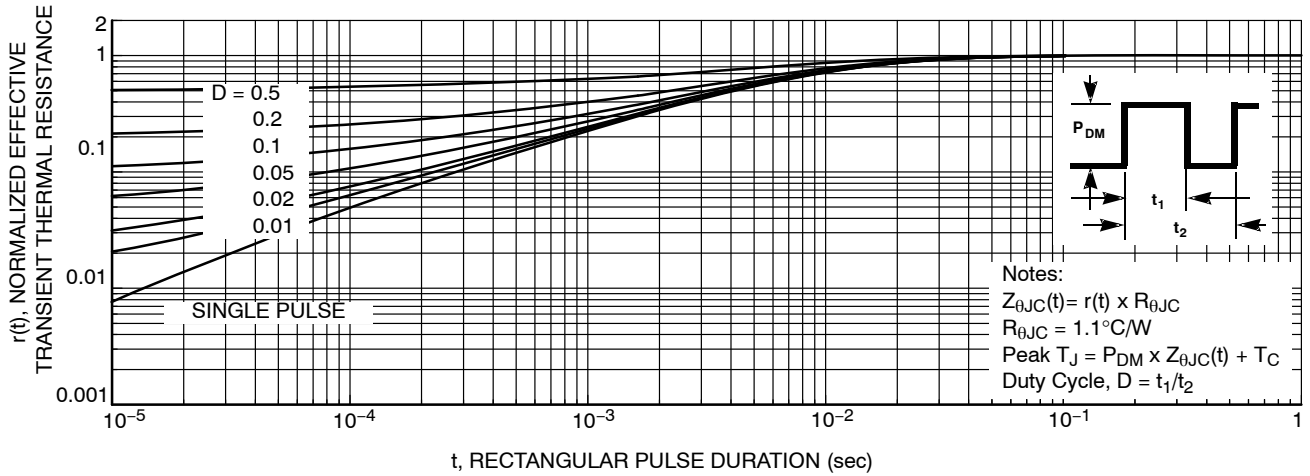


Figure 13. Transient Thermal Response Curve

ORDERING INFORMATION

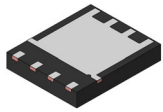
| Device Marking | Device    | Package                 | Reel Size | Tape Width | Shipping†            |
|----------------|-----------|-------------------------|-----------|------------|----------------------|
| FDMS86255      | FDMS86255 | PQFN8<br>(Halogen Free) | 13"       | 12 mm      | 3000 / Tape and Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

# MECHANICAL CASE OUTLINE

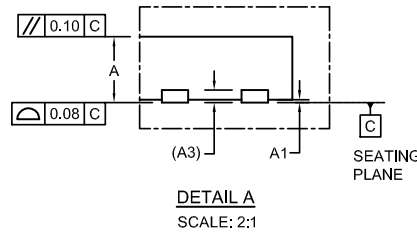
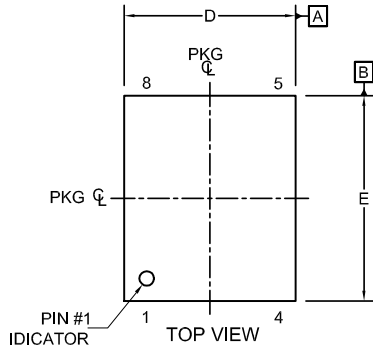
## PACKAGE DIMENSIONS

ON Semiconductor®



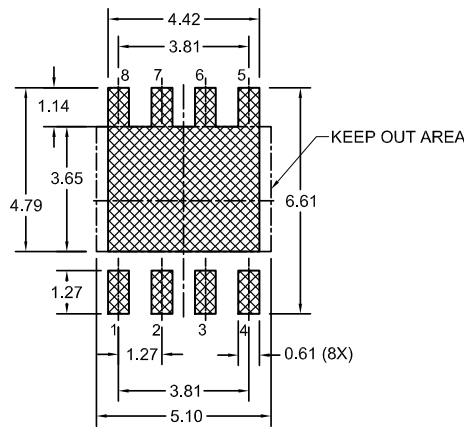
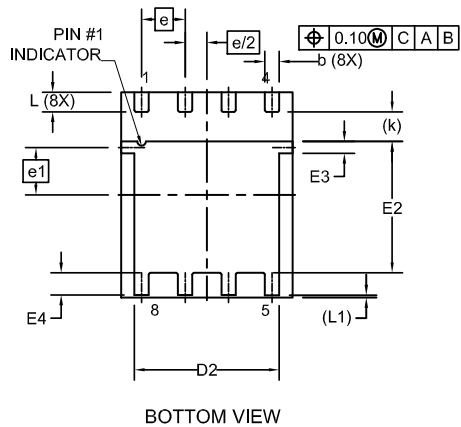
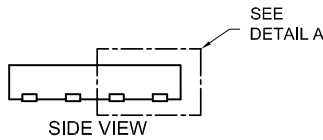
### PQFN8 5X6, 1.27P CASE 483AG ISSUE A

DATE 25 JUN 2021



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.



#### LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

| DIM | MILLIMETERS |      |      |
|-----|-------------|------|------|
|     | MIN.        | NOM. | MAX. |
| A   | 0.90        | 1.00 | 1.10 |
| A1  | 0.00        | -    | 0.05 |
| A3  | 0.20 REF    |      |      |
| b   | 0.37        | 0.42 | 0.47 |
| D   | 4.90        | 5.00 | 5.10 |
| D2  | 4.13        | 4.23 | 4.33 |
| E   | 5.90        | 6.00 | 6.10 |
| E2  | 3.74        | 3.84 | 3.94 |
| E3  | 0.25        | 0.35 | 0.45 |
| E4  | 0.60        | 0.70 | 0.80 |
| e   | 1.27 BSC    |      |      |
| e/2 | 0.635 BSC   |      |      |
| e1  | 1.31 BSC    |      |      |
| k   | 0.86 REF    |      |      |
| L   | 0.47        | 0.57 | 0.67 |
| L1  | 0.08REF     |      |      |

|                         |                         |  |
|-------------------------|-------------------------|--|
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